



RECEIVED  
DEC 18 2002  
TC 1700

INFORMATION DISCLOSURE CITATION PTO-1449	Atty. Docket No. 020307	Serial No. 10/088,107
	Applicant(s): TANAKA, Hisakazu et al.	
	Filing Date: March 22, 2002	Group Art Unit: Unassigned

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
T.2	AA	5,756,447	Hall	5/26/98		
	AB					
	AC					
	AD					
	AE					

FOREIGN PATENT DOCUMENTS

Document No.	Date	Country	Translation (Yes or No)

OTHER DOCUMENTS

	AK	
	AL	
Examiner	<i>Daley</i>	Date Considered 2/26/04

10/088107

22 MAR 2002

INFORMATION DISCLOSURE STATEMENT PTO-1449	Atty. Docket No. 020307	Serial No. New Appln.
	Applicant(s): Hisakazu TANAKA et al.	
	Filing Date: March 22, 2002	Group Art Unit:

## U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
_____	AA					
_____	AB					
_____	AC					
_____	AD					

## FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)	
<u>T. 2.</u>	AE	2000-290370	10/17/2000	Japan	Abstract. See PCT search rpt.
_____	AF	2000-281915	10/10/2000	Japan	Abstract. See PCT search rpt.
_____	AG	2000-63511	02/29/2000	Japan	Abstract. See PCT search rpt.
_____	AH	11-60729	03/05/99	Japan	Abstract. See PCT search rpt.
_____	AI	11-158266	06/15/99	Japan	Abstract. See PCT search rpt.
_____	AJ	10-298282	11/10/98	Japan	Abstract. See PCT search rpt.
_____	AK	7-310021	11/28/95	Japan	Abstract. Discussed in the spec.
_____	AL	9-143210	06/03/97	Japan	Abstract. Discussed in the spec.
_____	AM	10-81714	03/31/98	Japan	Abstract. Discussed in the spec.
✓	AN	3-93815	04/18/91	Japan	Abstract. Discussed in the spec.
<u>T. 2.</u>	AO	62-27408	02/05/87	Japan	Abstract. Discussed in the spec.
_____	AP				
_____	AQ				
_____	AR				
_____	AS				
_____	AT				
_____	AU				
_____	AV				
_____	AW				

Examiner

Date Considered

2/26/04